

US005880467A

# United States Patent [19]

## Martinis et al.

# [11] Patent Number:

5,880,467

[45] **Date of Patent:** 

Mar. 9, 1999

#### [54] MICROCALORIMETER X-RAY DETECTORS WITH X-RAY LENS

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[21] Appl. No.: 811,939

[56]

[22] Filed: Mar. 5, 1997

 [51] Int. Cl.6
 G02B 5/124

 [52] U.S. Cl.
 250/310

 [58] Field of Search
 250/310, 306,

250/307, 505.1; 378/43, 145

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#### [57] ABSTRACT

Spectroscopic materials analysis wherein a sample under test is bombarded by electrons in a scanning electron microscope to produce an x-ray emission collected over a large solid angle by a polycapillary lens and focused onto the surface of a microcalorimeter detector. The x-ray lens is used to increase the effective collection area of the microcalorimeter detector used in an x-ray spectrometer. By increasing the collection angle, the time period for x-ray collection is reduced and the detector can be located farther from the x-ray source. The x-ray lens is effective over a broad energy range of x-rays, thus providing compatibility with spectroscopic analysis. The microcalorimeter can be calibrated to compensate for any variations in the transmission efficiency of the x-ray lens.

#### 17 Claims, 1 Drawing Sheet

